

monolithic dual n-channel JFETs designed for . . .



Performance Curves NQP
See Section 4

- **Low and Medium Frequency Differential Amplifiers**
- **High Input Impedance Amplifiers**

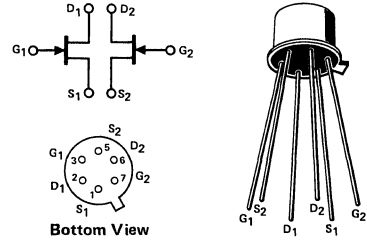
BENEFITS

- **Wide Dynamic Range**
 I_G Specified @ $V_{DS} = 20$ V
- **Low Capacitance**
 $C_{iss} < 4$ pF

***ABSOLUTE MAXIMUM RATINGS (25°C)**

Any Lead-To-Case Voltage ± 100 V
 Gate-Drain or Gate-Source Voltage -50 V
 Gate Current 50 mA
 Total Device Dissipation at (Each Side) 250 mW
 85°C Case Temperature (Both Sides) 500 mW
 Power Derating (Each Side) 2.86 mW/°C
 (Both Sides) 4.3 mW/°C
 Storage Temperature Range -65 to +250°C
 Lead Temperature (1/16" from case for 10 seconds) . . . 300°C

TO-71
See Section 6



***ELECTRICAL CHARACTERISTICS (25°C unless otherwise noted)**

Characteristic		2N3956		2N3957		2N3958		Unit	Test Conditions	
		Min	Max	Min	Max	Min	Max			
1	IGSS	Gate Reverse Current						pA	VGS = -30 V, VDS = 0	TA = 150°C
				-100		-100				
2	BVGS	Gate-Source Breakdown Voltage		-50		-50		nA	VDS = 0 V, IG = -1 μA	TA = 150°C
				-500		-500				
3	VGS(off)	Gate-Source Cutoff Voltage		-1.0		-1.0		V	VDS = 20 V, ID = 1 nA	TA = 125°C
				-4.5		-4.5				
4	VGS(f)	Gate-Source Forward Voltage		2.0		2.0		V	VDS = 0 V, IG = 1 mA	TA = 125°C
				-4.2		-4.2				
5	VGS	Gate-Source Voltage		-0.5		-0.5		pA	VDS = 20 V, ID = 50 μA	TA = 125°C
				-4.0		-4.0				
6	IG	Gate Operating Current		-50		-50		nA	VDS = 20 V, ID = 200 μA	TA = 125°C
				-250		-250				
7	IDSS	Saturation Drain Current		0.5		0.5		mA	VDS = 20 V, VGS = 0	TA = 125°C
				5.0		5.0				
8	yfs	Common-Source Forward Transconductance		1000		1000		μmho	VDS = 20 V, VGS = 0	f = 1 kHz
				3000		3000				
9	gos	Common-Source Output Conductance		35		35		pF	VDS = 20 V, VGS = 0	f = 200 MHz
				4.0		4.0				
10	Ciss	Common-Source Input Capacitance		1.2		1.2		pF	VDS = 20 V, VGS = 0	f = 1 kHz
				1.5		1.5				
11	Crss	Common-Source Reverse Transfer Capacitance		1.5		1.5		dB	VDS = 20 V, VGS = 0 V, RG = 10 MΩ	f = 1 MHz
				1.5		1.5				
12	Cdgo	Drain-Gate Capacitance		0.5		0.5		nA	VDS = 20 V, ID = 200 μA	f = 100 Hz
				10		10				
13	NF	Common-Source Spot Noise Figure		0.5		0.5		mV	VDS = 20 V, ID = 200 μA	T = 125°C
				15		20				
14	IG1-IG2	Differential Gate Reverse Current		10		10		mV	VDS = 20 V, ID = 200 μA	T = 25°C to -55°C
				10		10				
15	IDSS1/IDSS2	Saturation Drain Current Ratio (Note 1)		0.95		0.95		mV	VDS = 20 V, ID = 200 μA	T = 25°C to 125°C
				1.0		1.0				
16	VGS1-VGS2	Differential Gate-Source Voltage		4.0		6.0		mV	VDS = 20 V, ID = 200 μA	f = 1 kHz
				5.0		7.5				
17	ΔVGS1-VGS2	Gate-Source Voltage Differential Change With Temperature		4.0		6.0		mV	VDS = 20 V, ID = 200 μA	T = 25°C to -55°C
				5.0		7.5				
18	9fs1/9fs2	Transconductance Ratio (Note 1)		0.95		0.95		-	VDS = 20 V, ID = 200 μA	f = 1 kHz
				1.0		1.0				

*JEDEC registered data
 NOTE:
 1. Assumes smaller value in numerator.

NQP